

<b>Notice of References Cited</b>	Application/Control No. 10/601,926	Applicant(s)/Patent Under Reexamination HAGERTY, JON C.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,250,073	06-2001	Zimmer et al.	60/281
	B	US-5,419,124	05-1995	Adamczyk et al.	60/274
	C	US-5,761,902	06-1998	Usami et al.	60/288
	D	US-6,122,908	09-2000	Wirmark, Goran	60/274
	E	US-6,240,725	06-2001	Scappatura, Dominic E.	60/311
	F	US-2003/0233825	12-2003	Asanuma et al.	60/278
	G	US-2004/0060283	04-2004	Lee, Ju-Chel	060/281
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	DE 4342296 C1	11-1994	Germany	JORACH, RAINER DIPL ING	F01N 03/20
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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